

# NL17SHT00

## Single 2-Input NAND Gate/ CMOS Logic Level Shifter LSTTL-Compatible Inputs

The NL17SHT00 is a single gate 2-input NAND fabricated with silicon gate CMOS technology.

The internal circuit is composed of multiple stages, including a buffer output which provides high noise immunity and stable output.

The device input is compatible with TTL-type input thresholds and the output has a full 5 V CMOS level output swing. The input protection circuitry on this device allows overvoltage tolerance on the input, allowing the device to be used as a logic-level translator from 3 V CMOS logic to 5 V CMOS Logic or from 1.8 V CMOS logic to 3 V CMOS Logic while operating at the high voltage power supply.

The NL17SHT00 input structure provides protection when voltages up to 7 V are applied, regardless of the supply voltage. This allows the NL17SHT00 to be used to interface 5 V circuits to 3 V circuits. The output structures also provide protection when  $V_{CC} = 0$  V. These input and output structures help prevent device destruction caused by supply voltage – input/output voltage mismatch, battery backup, hot insertion, etc.

### Features

- High Speed:  $t_{PD} = 3.1$  ns (Typ) at  $V_{CC} = 5$  V
- Low Power Dissipation:  $I_{CC} = 1$   $\mu$ A (Max) at  $T_A = 25^\circ$ C
- TTL-Compatible Inputs:  $V_{IL} = 0.8$  V;  $V_{IH} = 2$  V
- CMOS-Compatible Outputs:  $V_{OH} > 0.8 V_{CC}$ ;  $V_{OL} < 0.1 V_{CC}$  @Load
- Power Down Protection Provided on Inputs and Outputs
- Balanced Propagation Delays
- Pin and Function Compatible with Other Standard Logic Families
- These are Pb-Free Devices

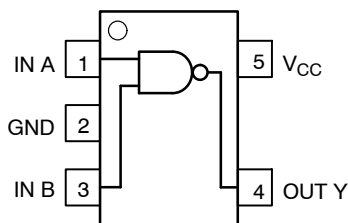


Figure 1. Pinout

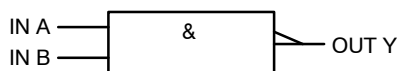


Figure 2. Logic Symbol



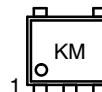
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### MARKING DIAGRAM



SOT-953  
CASE 527AE



K = Specific Device Code  
M = Month Code

### PIN ASSIGNMENT

|   |          |
|---|----------|
| 1 | IN A     |
| 2 | GND      |
| 3 | IN B     |
| 4 | OUT Y    |
| 5 | $V_{CC}$ |

### FUNCTION TABLE

| Inputs |   | Output |
|--------|---|--------|
| A      | B | Y      |
| L      | L | H      |
| L      | H | H      |
| H      | L | H      |
| H      | H | L      |

### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 4 of this data sheet.

# NL17SHT00

## MAXIMUM RATINGS

| Symbol               | Characteristics  | Value  | Unit |
|----------------------|--|--|------|
| V <sub>CC</sub>      | DC Supply Voltage  | -0.5 to +7.0                                 | V    |
| V <sub>IN</sub>      | DC Input Voltage   | -0.5 to +7.0                                 | V    |
| V <sub>OUT</sub>     | DC Output Voltage<br>V <sub>CC</sub> = 0<br>High or Low State                      | -0.5 to 7.0<br>-0.5 to V <sub>CC</sub> + 0.5 | V    |
| I <sub>IK</sub>      | Input Diode Current  | -20  | mA   |
| I <sub>OK</sub>      | Output Diode Current<br>V <sub>OUT</sub> < GND; V <sub>OUT</sub> > V <sub>CC</sub> | ±20  | mA   |
| I <sub>OUT</sub>     | DC Output Current  | ±25  | mA   |
| I <sub>CC</sub>      | DC Supply Current, V <sub>CC</sub> and GND   | 50   | mA   |
| T <sub>STG</sub>     | Storage Temperature Range  | -65 to +150                                  | °C   |
| T <sub>L</sub>       | Lead Temperature, 1 mm from Case for 10 Seconds                                    | 260  | °C   |
| T <sub>J</sub>       | Junction Temperature Under Bias  | +150   | °C   |
| P <sub>D</sub>       | Power Dissipation in Still Air at 85°C   | 50   | mW   |
| MSL                  | Moisture Sensitivity   | Level 1                                      |      |
| F <sub>R</sub>       | Flammability Rating<br>Oxygen Index: 28 to 34                                      | UL 94 V-0 @ 0.125 in                         |      |
| I <sub>LATCHUP</sub> | Latchup Performance<br>Above V <sub>CC</sub> and Below GND at 125°C (Note 1)       | ±100   | mA   |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Tested to EIA/JESD78.

## RECOMMENDED OPERATING CONDITIONS

| Symbol                          | Characteristics  | Min        | Max                    | Unit |
|---------------------------------|--|------------|------------------------|------|
| V <sub>CC</sub>                 | DC Supply Voltage  | 3.0        | 5.5                    | V    |
| V <sub>IN</sub>                 | DC Input Voltage   | 0.0        | 5.5                    | V    |
| V <sub>OUT</sub>                | DC Output Voltage<br>V <sub>CC</sub> = 0<br>High or Low State                                  | 0.0<br>0.0 | 5.5<br>V <sub>CC</sub> | V    |
| T <sub>A</sub>                  | Operating Temperature Range  | -55        | +125                   | °C   |
| t <sub>r</sub> , t <sub>f</sub> | Input Rise and Fall Time<br>V <sub>CC</sub> = 3.3 V ± 0.3 V<br>V <sub>CC</sub> = 5.0 V ± 0.5 V | 0<br>0     | 100<br>20              | ns/V |

## Device Junction Temperature versus Time to 0.1% Bond Failures

| Junction Temperature °C | Time, Hours | Time, Years |
|-------------------------|-------------|-------------|
| 80                      | 1,032,200   | 117.8       |
| 90                      | 419,300     | 47.9        |
| 100                     | 178,700     | 20.4        |
| 110                     | 79,600      | 9.4         |
| 120                     | 37,000      | 4.2         |
| 130                     | 17,800      | 2.0         |
| 140                     | 8,900       | 1.0         |

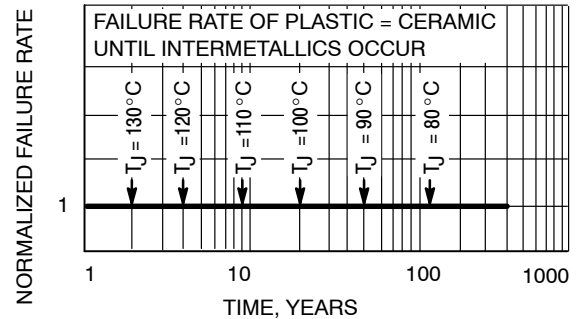


Figure 3. Failure Rate vs. Time Junction Temperature

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## DC ELECTRICAL CHARACTERISTICS

| Symbol             | Parameter   | Test Conditions  | V <sub>CC</sub><br>(V) | T <sub>A</sub> = 25°C |            |                    | T <sub>A</sub> ≤ 85°C |                    | -55 ≤ T <sub>A</sub> ≤ 125°C |                    | Unit |
|--------------------|---|--|------------------------|-----------------------|------------|--------------------|-----------------------|--------------------|------------------------------|--------------------|------|
|                    |   |  |                        | Min                   | Typ        | Max                | Min                   | Max                | Min                          | Max                |      |
| V <sub>IH</sub>    | Minimum High-Level Input Voltage  |  | 3.0<br>4.5<br>5.5      | 1.4<br>2.0<br>2.0     |            |                    | 1.4<br>2.0<br>2.0     |                    | 1.4<br>2.0<br>2.0            |                    | V    |
| V <sub>IL</sub>    | Maximum Low-Level Input Voltage   |  | 3.0<br>4.5<br>5.5      |                       |            | 0.53<br>0.8<br>0.8 |                       | 0.53<br>0.8<br>0.8 |                              | 0.53<br>0.8<br>0.8 | V    |
| V <sub>OH</sub>    | Minimum High-Level Output Voltage<br>V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> | V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub><br>I <sub>OH</sub> = -50 μA                           | 3.0<br>4.5             | 2.9<br>4.4            | 3.0<br>4.5 |                    | 2.9<br>4.4            |                    | 2.9<br>4.4                   |                    | V    |
|                    |   | V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub><br>I <sub>OH</sub> = -4 mA<br>I <sub>OH</sub> = -8 mA | 3.0<br>4.5             | 2.58<br>3.94          |            |                    | 2.48<br>3.80          |                    | 2.34<br>3.66                 |                    | V    |
| V <sub>OL</sub>    | Maximum Low-Level Output Voltage<br>V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>  | V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub><br>I <sub>OL</sub> = 50 μA                            | 3.0<br>4.5             |                       | 0.0<br>0.0 | 0.1<br>0.1         |                       | 0.1<br>0.1         |                              | 0.1<br>0.1         | V    |
|                    |   | V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub><br>I <sub>OL</sub> = 4 mA<br>I <sub>OL</sub> = 8 mA   | 3.0<br>4.5             |                       |            | 0.36<br>0.36       |                       | 0.44<br>0.44       |                              | 0.52<br>0.52       | V    |
| I <sub>IN</sub>    | Maximum Input Leakage Current   | V <sub>IN</sub> = 5.5 V or GND   | 0 to 5.5               |                       |            | ±0.1               |                       | ±1.0               |                              | ±1.0               | μA   |
| I <sub>CC</sub>    | Maximum Quiescent Supply Current  | V <sub>IN</sub> = V <sub>CC</sub> or GND   | 5.5                    |                       |            | 1.0                |                       | 20                 |                              | 40                 | μA   |
| I <sub>CC(T)</sub> | Quiescent Supply Current  | Input: V <sub>IN</sub> = 3.4 V   | 5.5                    |                       |            | 1.35               |                       | 1.50               |                              | 1.65               | mA   |
| I <sub>OFF</sub>   | Power Off Output Leakage Current  | V <sub>OUT</sub> = 5.5 V   | 0.0                    |                       |            | 0.5                |                       | 5.0                |                              | 10                 | μA   |

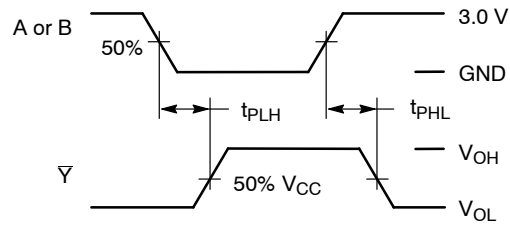
## AC ELECTRICAL CHARACTERISTICS Input t<sub>r</sub> = t<sub>f</sub> = 3.0 ns

| Symbol                                 | Parameter                                    | Test Conditions   | T <sub>A</sub> = 25°C |            |              | T <sub>A</sub> ≤ 85°C |              | -55 ≤ T <sub>A</sub> ≤ 125°C |              | Unit |
|--|--|---|-----------------------|------------|--------------|-----------------------|--------------|------------------------------|--------------|------|
|  |  |   | Min                   | Typ        | Max          | Min                   | Max          | Min                          | Max          |      |
| t <sub>PLH</sub> ,<br>t <sub>PHL</sub> | Maximum Propagation Delay, Input A or B to Y | V <sub>CC</sub> = 3.3 ± 0.3 V<br>C <sub>L</sub> = 15 pF<br>C <sub>L</sub> = 50 pF |                       | 4.1<br>5.5 | 10.0<br>13.5 |                       | 11.0<br>15.0 |                              | 13.0<br>17.5 | ns   |
|  |  | V <sub>CC</sub> = 5.0 ± 0.5 V<br>C <sub>L</sub> = 15 pF<br>C <sub>L</sub> = 50 pF |                       | 3.1<br>3.6 | 6.9<br>7.9   |                       | 8.0<br>9.0   |                              | 9.5<br>10.5  |      |
| C <sub>IN</sub>                        | Maximum Input Capacitance                    |   |                       | 5.5<br>10  |              |                       | 10           |                              | 10           | pF   |

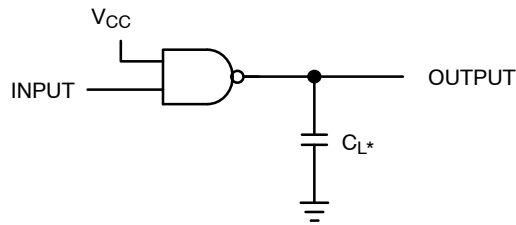
| C <sub>PD</sub> | Power Dissipation Capacitance (Note 2) | Typical @ 25°C, V <sub>CC</sub> = 5.0 V |  | pF |
|-----------------|--|---|--|----|
|                 |  | 11                                      |  |    |
|                 |  |   |  |    |

2. C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation: I<sub>CC(OPR)</sub> = C<sub>PD</sub> • V<sub>CC</sub> • f<sub>in</sub> + I<sub>CC</sub>. C<sub>PD</sub> is used to determine the no-load dynamic power consumption; P<sub>D</sub> = C<sub>PD</sub> • V<sub>CC</sub><sup>2</sup> • f<sub>in</sub> + I<sub>CC</sub> • V<sub>CC</sub>.

## NL17SHT00



**Figure 4. Switching Waveforms**



\*Includes all probe and jig capacitance.  
A 1-MHz square input wave is recommended for propagation delay tests.

**Figure 5. Test Circuit**

### ORDERING INFORMATION

| Device         | Package              | Shipping <sup>†</sup> |
|----------------|----------------------|-----------------------|
| NL17SHT00P5T5G | SOT-953<br>(Pb-Free) | 8000 / Tape & Reel    |

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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